CD74ACT32-Q1 QUADRUPLE 2-INPUT POSITIVE-OR GATE

SCHS351A - JANUARY 2004 - REVISED JANUARY 2008

 Qualified for Automotive Applications Inputs Are TTL-Voltage Compatible 		M PACKAGE (TOP VIEW)				
Buffered Inputs	1A 1 14	l II v _{cc}				
 Speed of Bipolar F, AS, and S, With Significantly Reduced Power Consumption 	1B 2 13 1Y 3 12] 4B] 4A				
Balanced Propagation Delays	2A 4 11	4Y				
 ±24-mA Output Drive Current Fanout to 15 F Devices 	2B [5 10 2Y [6 9]] 3B] 3A				
SCR-Latchup-Resistant CMOS Process and Circuit Design	GND [7 8] 3Y				

description/ordering information

The CD74ACT32 is a quadruple 2-input positive-OR gate. This device performs the Boolean function $Y = \overline{A} \bullet \overline{B}$ or Y = A + B in positive logic.

ORDERING INFORMATION[†]

T _A	PACKAGE‡		ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 125°C	SOIC - M	Tape and reel	CD74ACT32QM96Q1	ACT32Q

[†] For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at http://www.ti.com.

FUNCTION TABLE (each gate)

INP	JTS	OUTPUT
Α	В	Υ
Н	Χ	Н
X	Н	Н
L	L	L

logic diagram (positive logic)





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



[‡] Package drawings, thermal data, and symbolization are available at http://www.ti.com/packaging.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	$-0.5\ V$ to 6 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) (see Note 1)	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC}) (see Note 1)	±50 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND	±100 mA
Package thermal impedance, θ_{JA} (see Note 2)	86°C/W
Storage temperature range, T _{stg}	-65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 3)

		T _A = 2	T _A = 25°C		–40°C to 125°C	
		MIN	MAX	MIN	MAX	
V_{CC}	Supply voltage	4.5	5.5	4.5	5.5	V
V_{IH}	High-level input voltage	2		2		V
V_{IL}	Low-level input voltage		8.0		0.8	V
VI	Input voltage	0	V_{CC}	0	V_{CC}	V
V _O	Output voltage	0	V_{CC}	0	V_{CC}	V
I _{OH}	High-level output current		-24		-24	mA
I _{OL}	Low-level output current		24		24	mA
Δt/Δν	Input transition rise or fall rate		10		10	ns/V

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	T _A = 25°C		–40°C to 125°C		UNIT	
			MIN	MAX	MIN	MAX		
		$I_{OH} = -50 \mu A$	4.5 V	4.4		4.4		
V _{OH}	$V_{I} = V_{IH}$ or V_{IL}	$I_{OH} = -24 \text{ mA}$	4.5 V	3.94		3.7		V
		$I_{OH} = -50 \text{ mA}^{\dagger}$	5.5 V			3.85		
	$V_I = V_{IH}$ or V_{IL}	$I_{OL} = 50 \mu A$	4.5 V		0.1		0.1	
V _{OL}		I _{OL} = 24 mA	4.5 V		0.36		0.5	V
		$I_{OL} = 50 \text{ mA}^{\dagger}$	5.5 V				1.65	
l _l	V _I = V _{CC} or GND		5.5 V		±0.1		±1	μΑ
Icc	$V_I = V_{CC}$ or GND,	I _O = 0	5.5 V		4		80	μΑ
Δ l $_{CC}$ ‡	V _I = V _{CC} – 2.1 V		4.5 V to 5.5 V		2.4		3	mA
C _i					10		10	pF

[†] Test one output at a time, not exceeding 1-second duration. Measurement is made by forcing indicated current and measuring voltage to minimize power dissipation. Test verifies a minimum 75-Ω transmission-line drive capability at 125°C.

ACT INPUT LOAD TABLE

INPUT	UNIT LOAD
All	0.42

Unit load is ΔI_{CC} limit specified in electrical characteristics table (e.g., 2.4 mA at 25°C).

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V, C_L = 50 pF (unless otherwise noted) (see Figure 1)

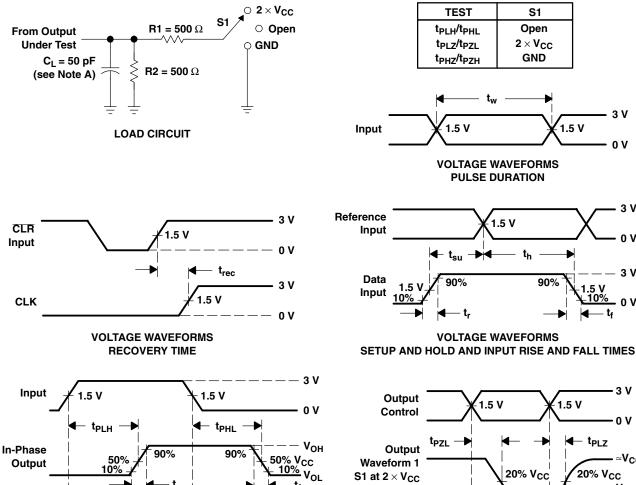
	PARAMETER	FROM (INPUT)	TO (OUTPUT)	-40°0 125		UNIT
		(INPOT)	(001P01)	MIN	MAX	
Ī	t _{PLH}	A or D	V	3	12.1	
	t _{PHL}	A or B	ĭ	3	12.1	ns

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

	PARAMETER	TYP	UNIT
C	Power dissipation capacitance	47	pF

[‡] Additional quiescent supply current per input pin, TTL inputs high, 1 unit load

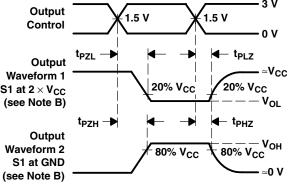
PARAMETER MEASUREMENT INFORMATION



VOLTAGE WAVEFORMS PROPAGATION DELAY AND OUTPUT TRANSITION TIMES

50% V_{CC}

10%



VOLTAGE WAVEFORMS OUTPUT ENABLE AND DISABLE TIMES

NOTES: A. C_L includes probe and test-fixture capacitance.

t_{PHL}

Out-of-Phase

Output

90%

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

 V_{OH}

- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_f = 3 \text{ ns}$, $t_f = 3 \text{ ns}$. Phase relationships between waveforms are arbitrary.
- D. For clock inputs, f_{max} is measured with the input duty cycle at 50%.
- E. The outputs are measured one at a time with one input transition per measurement.
- F. t_{PLH} and t_{PHL} are the same as t_{pd}.
- G. t_{PZI} and t_{PZH} are the same as t_{en}.
- H. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- I. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms



6-Jan-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Samples
	(1)		Drawing			(2)		(3)	(Requires Login)
CD74ACT32QM96G4Q1	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74ACT32QM96Q1	OBSOLETE	SOIC	D	14		TBD	Call TI	Call TI	
CD74ACT32QPWRQ1	OBSOLETE	TSSOP	PW	14		TBD	Call TI	Call TI	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF CD74ACT32-Q1:

Catalog: CD74ACT32

Military: CD54ACT32

PACKAGE OPTION ADDENDUM



6-Jan-2013

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



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